

Search Notes



Application/Control No.

10/782,723

Examiner

Kin-Chan Chen

Applicant(s)/Patent under Reexamination

WANG ET AL.

Art Unit

1765

SEARCHED

Class	Subclass	Date	Examiner
438	700	1/9/2006	KCC
	706		
	710		
	714		
	715		
	718		
438	719	1/9/06	KCC
updated		10/17/06	KCC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
438	700	10/17/06	KCC
	706		
	710		
	714		
	715		
	718		
438	719	10/17/06	KCC

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
East key word search USPAT, USPG-pub. Epo, Jpo, Derwent IBM-DOB inventor search	1/9/2006	KCC
updated	10/17/06	KCC